NOTES:

- 1. SUBSTRATE: Fused Silica
- 2. SURFACE \$1 TO BE PARALLEL TO SURFACE \$2 TO WITHIN <3 ARCMINS
- 3. COATING (APPLY ACROSS COATING APERTURE)

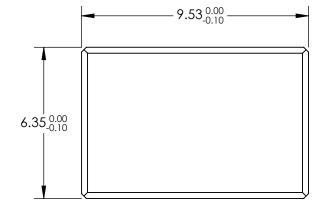
S1: R(ABS) >99.8% @ 1030nm R(ABS) >99.5% @ 1020 - 1040nm DAMAGE THRESHOLD, PULSED: 20 J/cm² @ 1030nm, 20ns, 20Hz CW: 1 MW/cm² @ 1030nm

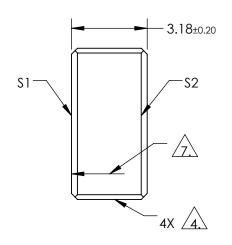
S2: NONE

4. FINE GROUND SURFACE

- 5. CLEAR APERTURE AND COATING APERTURE ARE CENTERED ON SURFACE
- 6. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE

ARROW ON EDGE WITH LASER ETCH, PENCIL, OR PERMANENT INK POINTS TOWARDS SURFACE \$1





FOR INFORMATION ONLY:
DO NOT MANUFACTURE
PARTS TO THIS DRAWING

SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

	\$1	\$2					
SHAPE	PLANO	PLANO				Edmund Optic	C®
SURFACE QUALITY	10-5	COMMERCIAL POLISH			W		,5°
SURFACE FLATNESS	0.10 WAVE	N/A	THIRD ANGLE PROJECTION		TITLE	6.35 x 9.53mm 1030nm 45°, Yb:YAG Laser Line	
MIN CLEAR APERTURE	5.40 x 8.10	N/A				Mirror	SI LING
MIN COATNG APERTURE	5.40 x 8.10	N/A		'			
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	11298	SHEET 1 OF 1